Notice of References Cited	Application/Control No. 10/589,333	Applicant(s)/Patent Under Reexamination OGAWA ET AL.		
	Examiner	Art Unit	Page 1 of 1	
	Hoang M. Nguyen	3748		

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,008,573	02-1977	Petrillo, Vincent Carmen	60/651
*	В	US-6,196,817	03-2001	Tsumagari et al.	418/55.6
	U	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	J	US-			
	К	US-			
	L_	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	C			
	>			
	w			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.